

L Number	Hits	Search Text	DB	Time stamp
1	66	((depth or deepness or measur\$5 or distance or disparity or range) or (range near3 find\$4)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane)with (camera near5(calibrat\$4 or readjust\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:44
2	8	((depth or deepness or measur\$5 or distance or disparity or range) or (range near3 find\$4)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane)with (camera near5(calibrat\$4 or readjust\$4))with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:46
3	11	((depth or deepness or measur\$5 or distance or disparity or range) or (range near3 find\$4)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane)with (camera with(calibrat\$4 or readjust\$4))with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:46
4	119	((depth or deepness or measur\$5 or distance or disparity or range) or (range near3 find\$4)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane)with (camera with(calibrat\$4 or readjust\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:56
5	331735	((depth or disparity or range)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane or information or value)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:57
6	4097	((depth or disparity or range)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane or information or value)with camera	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:58
7	292	((depth or disparity or range)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane or information or value)with camera with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 12:58
8	4	((depth or disparity or range)) near5 (map\$4 or chart or project\$4 or graph\$4 or picture or plane or information or value)with camera with pixel with (calibrat\$4 or readjust\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:06
9	0	6633664.URPN.	USPAT	2004/04/15 12:59
10	2	("5796427" "6342918").PN.	USPAT	2004/04/15 12:59
11	1617	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with view	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:18
12	31	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with (new near5 view)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:08
13	138	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with view with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:58
14	2	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with view with pixel with calibrat\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:24
15	6	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with view with calibrat\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:25

16	5	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image) with ((new or changed)near6 view) with camera	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:55
17	184	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image) with (view or perspective) with camera	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:55
18	12	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image) with (view or perspective) with camera with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:55
19	163	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with (view or parallax) with pixel	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 13:59
20	12	((depth or disparity)) near5 (map\$4 or picture or plane or information or value or image)with (view or parallax) with pixel with camera	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:25
21	4624	zhang near z	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:25
22	339	(zhang near z) and image	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:25
23	91	(zhang near z) and image and calibrat\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:25
24	71	(zhang near z) and image and calibrat\$4 and camera	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:25
25	21	(zhang near z) and image and calibrat\$4 and camera and depth	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:43
26	2	5511153.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:55
27	7	(depth near5 map\$4) with (new near6 view)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:58
28	11	(depth near5 map\$4) same (new near6 view)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/15 14:58

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Electronics Letters, Volume: 31, Issue: 4, 16 Feb. 1995

Pages:308 - 309

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2 Nearest neighbor rules using ordinal information*Yager, R.R.;*

IFSA World Congress and 20th NAFIPS International Conference, 2001. Joint 9th, Volume: 2, 25-28 July 2001

Pages:968 - 972 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(344 KB\)\]](#) **IEEE CNF**
3 The arc-transversal median algorithm: an approach to increasing ultrasonic sensor accuracy*Nagatani, K.; Choset, H.; Lazar, N.;*

Robotics and Automation, 1999. Proceedings. 1999 IEEE International Conference on, Volume: 1, 10-15 May 1999

Pages:644 - 651 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(712 KB\)\]](#) **IEEE CNF**
4 Error criteria analysis and robust data fusion*Xing Li; Weiru Fang; Qi Tian;*

Acoustics, Speech, and Signal Processing, 1994. ICASSP-94., 1994 IEEE International Conference on, Volume: iv, 19-22 April 1994

Pages:IV/37 - IV/40 vol.4

[\[Abstract\]](#) [\[PDF Full-Text \(216 KB\)\]](#) IEEE CNF

5 The power average operator

Yager, R.R.;

Systems, Man and Cybernetics, Part A, IEEE Transactions on , Volume: 31 , I
6 , Nov. 2001

Pages:724 - 731

[\[Abstract\]](#) [\[PDF Full-Text \(251 KB\)\]](#) IEEE JNL

6 Multimodal decision-level fusion for person authentication

Chatzis, V.; Bors, A.G.; Pitas, I.;

Systems, Man and Cybernetics, Part A, IEEE Transactions on , Volume: 29 , I
6 , Nov. 1999

Pages:674 - 680

[\[Abstract\]](#) [\[PDF Full-Text \(212 KB\)\]](#) IEEE JNL

7 Approximating fuzzy measures by hierarchically decomposable one:

Domingo-Ferrer, J.; Torra, V.;

Information Fusion, 2002. Proceedings of the Fifth International Conference
on , Volume: 1 , 8-11 July 2002

Pages:191 - 198 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(806 KB\)\]](#) IEEE CNF

8 Fuzzy rules for automated sensor self-validation and confidence measure

PhaniShankar, C.V.; Orth, S.; Frolik, J.; Abdelrahman, M.;

American Control Conference, 2000. Proceedings of the 2000 , Volume: 4 , 21
June 2000

Pages:2912 - 2916 vol.4

[\[Abstract\]](#) [\[PDF Full-Text \(288 KB\)\]](#) IEEE CNF

9 The ARIES-III D-³He tokamak reactor: design-point determination : parametric studies

Bathke, C.G.; Werley, K.A.; Miller, R.L.; Krakowski, R.A.; Santarius, J.F.;

Fusion Engineering, 1991. Proceedings., 14th IEEE/NPSS Symposium on , 30
Sept.-3 Oct. 1991

Pages:219 - 222 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(356 KB\)\]](#) IEEE CNF

10 Neural network based sensor array signal processing

Chung, D.; Merat, F.L.;

Multisensor Fusion and Integration for Intelligent Systems, 1996. IEEE/SICE/
International Conference on , 8-11 Dec. 1996

Pages:757 - 764

[\[Abstract\]](#) [\[PDF Full-Text \(628 KB\)\]](#) IEEE CNF

11 A theoretical study on six classifier fusion strategies*Kuncheva, L.I.;*

Pattern Analysis and Machine Intelligence, IEEE Transactions on , Volume: 24 , Issue: 2 , Feb. 2002

Pages:281 - 286

[\[Abstract\]](#) [\[PDF Full-Text \(159 KB\)\]](#) **IEEE JNL****12 Durable marine concrete for the U.S. Navy***Burke, D.F.;*

OCEANS 2000 MTS/IEEE Conference and Exhibition , Volume: 3 , 11-14 Sept.

Pages:1803 - 1814 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(956 KB\)\]](#) **IEEE CNF****13 Noise cancellation using nonlinear fuzzy filters***Russo, F.;*

Instrumentation and Measurement Technology Conference, 1997. IMTC/97. Proceedings. 'Sensing, Processing, Networking'. , IEEE , Volume: 2 , 19-21 May 1997

Pages:772 - 777 vol.2

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1 3-D scene data recovery using omnidirectional multibaseline stereo
Sing Bing Kang; Szeliski, R.;

 Computer Vision and Pattern Recognition, 1996. Proceedings CVPR '96, 1996 Computer Society Conference on , 18-20 June 1996
 Pages:364 - 370

[\[Abstract\]](#) [\[PDF Full-Text \(792 KB\)\]](#) **IEEE CNF**
2 Dynamic stereo with self-calibration
Tirumalai, A.P.; Schunck, B.G.; Jain, R.C.;

 Computer Vision, 1990. Proceedings, Third International Conference on , 4-7 1990
 Pages:466 - 470

[\[Abstract\]](#) [\[PDF Full-Text \(464 KB\)\]](#) **IEEE CNF**
3 Application of fuzzy signal processing to three dimensional vision
Hughes, N.R.; Roberts, G.N.; Wilson, G.R.;

 Factory 2000 - The Technology Exploitation Process, Fifth International Conference (Conf. Publ. No. 435) , 2-4 April 1997
 Pages:319 - 324

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